Form PTO 1449		U.S. DEPARTMENT	OF COMMERCE	ATTY DOCKET NO.		SERIAL NO. 10/568,969			
(Modified)		PATENT AND TRAI	DEMARK OFFICE	286085US6PCT					
				APPLICANT					
LIST OF	REFER	RENCES CITED BY AP	PLICANT	Junya OHDE, et al.	nya OHDE, et al.				
				FILING DATE		GROUP			
				October 10, 2006		2623			
U.S. PATENT DOCUMENTS									
EXAMINER		DOCUMENT	DATE	NAME	CLASS	SUB			
INITIAL		NUMBER	DATE	INAIVIE	CLA33	CLASS	CLASS IF APPROPRIATE		
	AA								
	AB								
	AC								
	AD								
	AE								
	AF								
	AG								
	АН						-		
	ΑI								
	AJ								
-	AK								
	AL								
-, · ···	AM								
	AN								
			FO	PEIGN PATENT DOCUMENTS	L ,	L			
FOREIGN PATENT DOCUMENTS									
ı		DOCUMENT	DATE	COUNTRY		TRANSLATION			
		NUMBER		Japan (submitting English Abstract and Unedited		YES NO			
	AO	JP 2000-112976	4/21/2000	Computer-Generated English Translation only, reference previously filed 02/22/2006)		×			
	AP	JP 2003-153304	5/23/2003	Japan (submitting English Abstract and Computer-Generated English Translation	Unedited on only,	x			
			-	reference previously filed 02/22/2006)  Japan (submitting English Abstract and	Unedited	<del> </del>	<del>-</del>		
	AQ	JP 2003-189333	7/4/2003	Computer-Generated English Translation	on only,	×			
				reference previously filed 02/22/2006)  Japan (submitting English Abstract and	Unedited				
	AR	JP 2002-125169	4/26/2002	Computer-Generated English Translation reference previously filed 02/22/2006)		×			
		ID 2004 295765	10/12/2001	Japan (with English Abstract and Unedi		×			
	AS	JP 2001-285765	10/12/2001	Computer-Generated English Translation  Japan (with English Abstract and Unedit	anslation)				
	AT	JP 2002-112186	4/12/2002	Computer-Generated English Translation	on)	х			
	AU	JP 2002-118838	4/19/2002	Japan (with English Abstract and Unedi Computer-Generated English Translation	on)	х			
	AV	JP 5-227494	9/3/1993	Japan (with English Abstract and Unedi Computer-Generated English Translation	rea on)	x			
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)									
	AW								
	AX								
	AY				··				
	AZ				Add	itional Ref	erences s	heet(s) attached	
Examiner					<del>                                     </del>	Considered			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in									
conformance and not considered. Include copy of this form with next communication to applicant.									